# **74ABT827**

# 10-bit buffer/line driver; non-inverting; 3-state Rev. 5 — 7 November 2011

**Product data sheet** 

#### **General description** 1.

The 74ABT827 high-performance BiCMOS device combines low static and dynamic power dissipation with high speed and high output drive.

The 74ABT827 10-bit buffers provide high performance bus interface buffering for wide data/address paths or buses carrying parity. They have NOR Output Enables (OE0, OE1) for maximum control flexibility.

#### **Features and benefits** 2.

- Ideal where high speed, light loading, or increased fan-in are required
- Flow-through pinout architecture for microprocessor oriented applications
- Output capability: +64 mA and -32 mA
- Power-up 3-state
- Inputs are disabled during 3-state mode
- Latch-up protection exceeds 500 mA per JESD78B class II level A
- ESD protection:
  - HBM JESD22-A114F exceeds 2000 V
  - MM JESD22-A115-A exceeds 200 V

#### **Ordering information** 3.

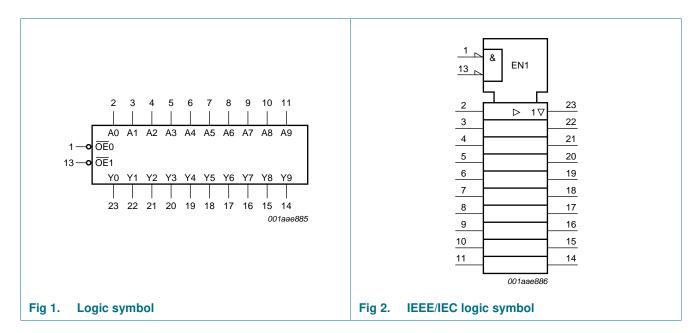
Table 1. **Ordering information** 

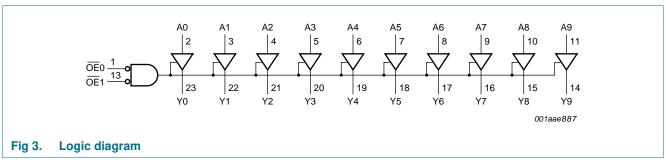
Type number	Package			
	Temperature range	Name	Description	Version
74ABT827D	–40 °C to +85 °C	SO24	plastic small outline package; 24 leads; body width 7.5 mm	SOT137-1
74ABT827DB	–40 °C to +85 °C	SSOP24	plastic shrink small outline package; 24 leads; body width 5.3 mm	SOT340-1
74ABT827PW	–40 °C to +85 °C	TSSOP24	plastic thin shrink small outline package; 24 leads; body width 4.4 mm	SOT355-1



10-bit buffer/line driver; non-inverting; 3-state

# 4. Functional diagram

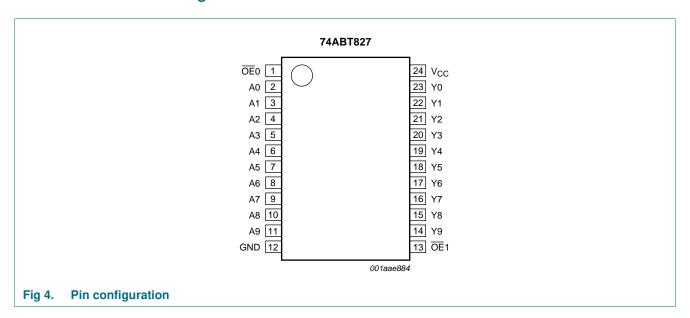




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# 5. Pinning information

# 5.1 Pinning



# 5.2 Pin description

Table 2. Pin description

Symbol	Pin	Description
OE0	1	output enable input (active LOW)
A0 to A9	2, 3, 4, 5, 6, 7, 8, 9, 10, 11	data input
GND	12	ground (0 V)
OE1	13	output enable input (active LOW)
Y0 to Y9	23, 22, 21, 20, 19, 18, 17, 16, 15, 14	data output
$V_{CC}$	24	supply voltage

# 6. Functional description

### 6.1 Function table

Table 3. Function table[1]

Inputs		Output	Operating mode
<del>OE</del> n	An	Yn	
L	L	L	transparent
L	Н	Н	transparent
Н	X	Z	high-impedance

<sup>[1]</sup> H = HIGH voltage level;

L = LOW voltage level;

X = don t care;

Z = high-impedance OFF-state.

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# 7. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
$V_{CC}$	supply voltage		-0.5	+7.0	V
VI	input voltage		<u>[1]</u> –1.2	+7.0	V
V <sub>O</sub>	output voltage	output in OFF-state or HIGH-state	<u>[1]</u> –0.5	+5.5	V
I <sub>IK</sub>	input clamping current	$V_1 < 0 V$	-18	-	mA
I <sub>OK</sub>	output clamping current	V <sub>O</sub> < 0 V	-50	-	mA
Io	output current	output in LOW-state	-	128	mA
Tj	junction temperature		[2] _	150	°C
T <sub>stg</sub>	storage temperature		-65	+150	°C

<sup>[1]</sup> The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

# 8. Recommended operating conditions

Table 5. Recommended operating conditions

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$V_{CC}$	supply voltage		4.5	-	5.5	V
V <sub>I</sub>	input voltage		0	-	$V_{CC}$	V
$V_{IH}$	HIGH-level input voltage		2.0	-	-	V
$V_{IL}$	LOW-level input voltage		-	-	0.8	V
I <sub>OH</sub>	HIGH-level output current		-32	-	-	mA
I <sub>OL</sub>	LOW-level output current		-	-	64	mA
$\Delta t/\Delta V$	input transition rise and fall rate		0	-	5	ns/V
T <sub>amb</sub>	ambient temperature	in free air	-40	-	+85	°C

<sup>[2]</sup> The performance capability of a high-performance integrated circuit in conjunction with its thermal environment can create junction temperatures which are detrimental to reliability. The maximum junction temperature of this integrated circuit should not exceed 150 °C.

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# 9. Static characteristics

Table 6. Static characteristics

Symbol	Parameter	Conditions			25 °C		–40 °C t	o +85 °C	Uni
				Min	Тур	Max	Min	Max	
V <sub>IK</sub>	input clamping voltage	$V_{CC} = 4.5 \text{ V}; I_{IK} = -18 \text{ mA}$		-1.2	-0.9	-	-1.2	-	٧
V <sub>OH</sub>	HIGH-level output	$V_I = V_{IL}$ or $V_{IH}$							
	voltage	$V_{CC} = 4.5 \text{ V}; I_{OH} = -3 \text{ mA}$		2.5	2.9	-	2.5	-	٧
		$V_{CC} = 5.0 \text{ V}; I_{OH} = -3 \text{ mA}$		3.0	3.4	-	3.0	-	٧
		$V_{CC} = 4.5 \text{ V}; I_{OH} = -32 \text{ mA}$		2.0	2.4	-	2.0	-	٧
V <sub>OL</sub>	LOW-level output voltage	$V_{CC}$ = 4.5 V; $I_{OL}$ = 64 mA; $V_{I}$ = $V_{IL}$ or $V_{IH}$		-	0.42	0.55	-	0.55	V
I <sub>I</sub>	input leakage current	$V_{CC} = 5.5 \text{ V}; V_I = \text{GND or } 5.5 \text{ V}$		-	±0.01	±1.0	-	±1.0	μΑ
I <sub>OFF</sub>	power-off leakage current	$V_{CC}$ = 0 V; $V_{I}$ or $V_{O} \le 4.5$ V		-	±5.0	±100	-	±100	μΑ
I <sub>O(pu/pd)</sub>	power-up/power-down output current	$V_{CC}$ = 2.0 V; $V_{O}$ = $0.5$ V; $V_{I}$ = GND or $V_{CC}$ ; $\overline{OE}$ n HIGH	[1]	-	±5.0	±50	-	±50	μΑ
loz	OFF-state output current	$V_{CC}$ = 5.5 V; $V_I$ = $V_{IL}$ or $V_{IH}$							
		$V_0 = 2.7 \text{ V}$		-	5.0	50	-	50	μΑ
		V <sub>O</sub> = 0.5 V		-	-5.0	-50	-	-50	μΑ
I <sub>LO</sub>	output leakage current	HIGH-state; $V_O = 5.5 \text{ V}$ ; $V_{CC} = 5.5 \text{ V}$ ; $V_I = \text{GND or } V_{CC}$		-	5.0	50	-	50	μΑ
I <sub>O</sub>	output current	$V_{CC} = 5.5 \text{ V}; V_{O} = 2.5 \text{ V}$	[2]	-180	-80	-50	-180	-50	mΑ
I <sub>CC</sub>	supply current	$V_{CC}$ = 5.5 V; $V_{I}$ = GND or $V_{CC}$							
		outputs HIGH-state		-	0.5	250	-	250	μΑ
		outputs LOW-state		-	25	38	-	38	mΑ
		outputs disabled		-	0.5	250	-	250	μΑ
Δl <sub>CC</sub>	additional supply current	per input pin; $V_{CC} = 5.5 \text{ V}$ ; one input at 3.4 V; other inputs at $V_{CC}$ or GND	[3]						
		outputs enabled		-	0.5	1.5	-	1.5	mΑ
		outputs 3-state, one data input		-	0.01	50	-	50	mA
		outputs 3-state; one enable input		-	0.5	1.5	-	1.5	mA
Cı	input capacitance	$V_I = 0 V \text{ or } V_{CC}$		-	4	-	-	-	рF
Co	output capacitance	outputs disabled; $V_O = 0 V$ or $V_{CC}$		-	7	-	-	-	pF

<sup>[1]</sup> This parameter is valid for any  $V_{CC}$  between 0 V and 2.1 V with a transition time of up to 10 ms. For  $V_{CC}$  = 2.1 V to  $V_{CC}$  = 5 V  $\pm$  10 %, a transition time of up to 100  $\mu$ s is permitted.

<sup>[2]</sup> Not more than one output should be tested at a time, and the duration of the test should not exceed one second.

<sup>[3]</sup> This is the increase in supply current for each input at 3.4 V.

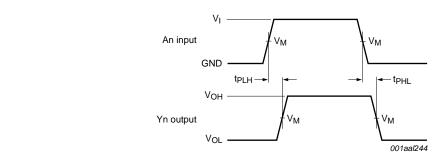
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# 10. Dynamic characteristics

**Table 7. Dynamic characteristics** *GND = 0 V; for test circuit, see <u>Figure 7</u>.* 

Symbol P	Parameter	Conditions		25 °C; <sub>C</sub> = 5.0		-40 °C to V <sub>CC</sub> = 5.0	Unit	
			Min	Тур	Max	Min	Max	
$t_{PLH}$	LOW to HIGH propagation delay	An to Yn; see Figure 5	1.1	3.0	4.4	1.1	4.8	ns
t <sub>PHL</sub>	HIGH to LOW propagation delay	An to Yn; see Figure 5	1.1	2.9	4.1	1.1	4.7	ns
t <sub>PZH</sub>	OFF-state to HIGH propagation delay	OEn to Yn; see Figure 6	1.6	3.7	5.1	1.6	5.9	ns
t <sub>PZL</sub>	OFF-state to LOW propagation delay	OEn to Yn; see Figure 6	2.6	4.6	5.9	2.6	6.9	ns
t <sub>PHZ</sub>	HIGH to OFF-state propagation delay	OEn to Yn; see Figure 6	2.0	4.8	6.3	2.0	6.8	ns
t <sub>PLZ</sub>	LOW to OFF-state propagation delay	OEn to Yn; see Figure 6	2.5	5.1	6.6	2.5	6.9	ns

## 11. Waveforms

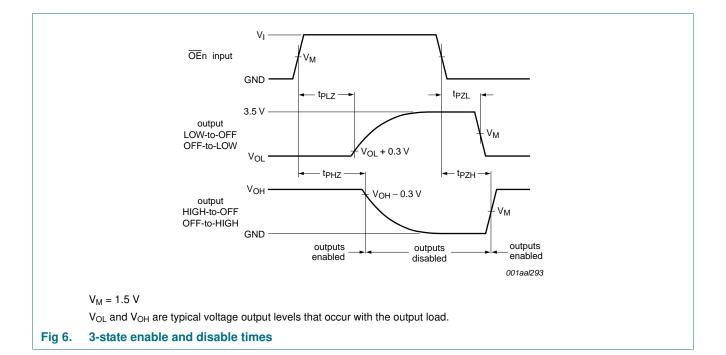


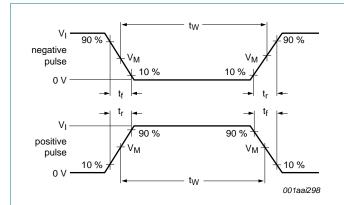
 $V_{M} = 1.5 V$ 

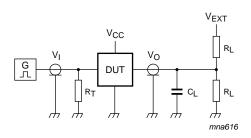
 $V_{\text{OL}}$  and  $V_{\text{OH}}$  are typical voltage output levels that occur with the output load.

Fig 5. Propagation delay input (An) to output (Yn)

### 10-bit buffer/line driver; non-inverting; 3-state







a. Input pulse definition

b. Test circuit

Test data and  $V_{EXT}$  levels are given in Table 8.

 $R_L$  = Load resistance.

 $C_L$  = Load capacitance including jig and probe capacitance.

 $R_{T}$  = Termination resistance should be equal to output impedance  $Z_{o}$  of the pulse generator.

 $V_{\text{EXT}}$  = Test voltage for switching times.

Fig 7. Test circuit for measuring switching times

Table 8. Test data

Input				Load		V <sub>EXT</sub>			
VI	$f_l$ $t_W$ $t_r$ , $t_f$		C <sub>L</sub>	C <sub>L</sub> R <sub>L</sub>		t <sub>PZH</sub> , t <sub>PHZ</sub>	t <sub>PZL</sub> , t <sub>PLZ</sub>		
3.0 V	1 MHz	500 ns	$\leq$ 2.5 ns	50 pF	$500 \Omega$	open	open	7.0 V	

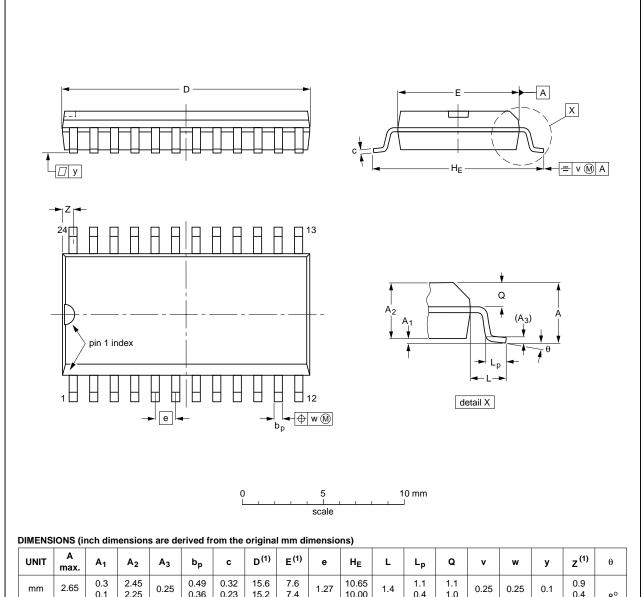
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# 12. Package outline

### SO24: plastic small outline package; 24 leads; body width 7.5 mm

SOT137-1



UNIT	A max.	A <sub>1</sub>	A <sub>2</sub>	A <sub>3</sub>	bp	С	D <sup>(1)</sup>	E <sup>(1)</sup>	е	HE	L	Lp	ø	v	w	у	z <sup>(1)</sup>	θ
mm	2.65	0.3 0.1	2.45 2.25	0.25	0.49 0.36	0.32 0.23	15.6 15.2	7.6 7.4	1.27	10.65 10.00	1.4	1.1 0.4	1.1 1.0	0.25	0.25	0.1	0.9 0.4	8°
inches	0.1	0.012 0.004	0.096 0.089	0.01	0.019 0.014	0.013 0.009	0.61 0.60	0.30 0.29	0.05	0.419 0.394	0.055	0.043 0.016	0.043 0.039	0.01	0.01	0.004	0.035 0.016	0°

#### Note

1. Plastic or metal protrusions of 0.15 mm (0.006 inch) maximum per side are not included.

OUTLINE		REFER	EUROPEAN	ISSUE DATE	
VERSION	IEC	JEDEC	JEITA	PROJECTION	ISSUE DATE
SOT137-1	075E05	MS-013			<del>99-12-27</del> 03-02-19

Fig 8. Package outline SOT137-1 (SO24)

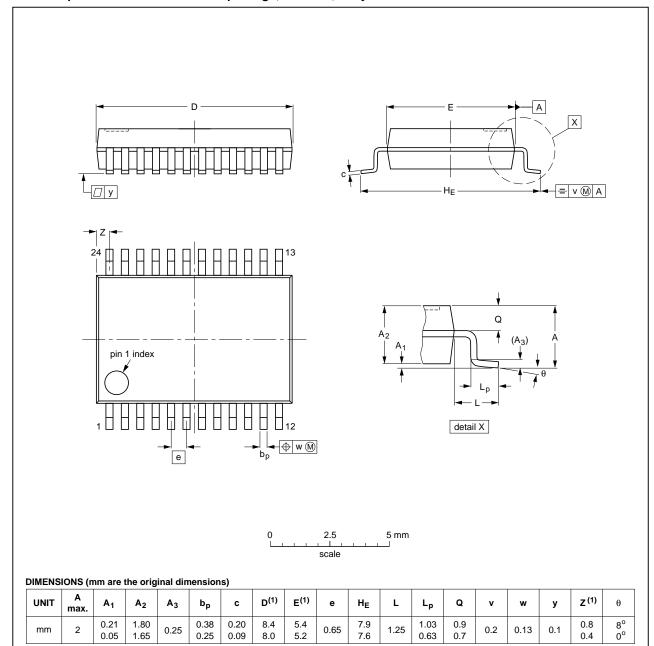
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10-bit buffer/line driver; non-inverting; 3-state

SSOP24: plastic shrink small outline package; 24 leads; body width 5.3 mm

SOT340-1



# Note

1. Plastic or metal protrusions of 0.2 mm maximum per side are not included.

OUTLINE		REFER	EUROPEAN	ISSUE DATE		
VERSION	IEC	IEC JEDEC JEITA		PROJECTION	ISSUE DATE	
SOT340-1		MO-150			<del>99-12-27</del> 03-02-19	

Fig 9. Package outline SOT340-1 (SSOP24)

74ABT827

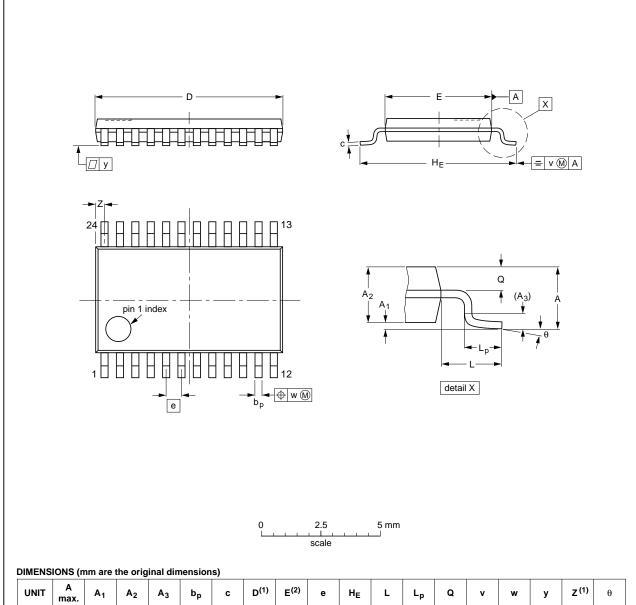
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10-bit buffer/line driver; non-inverting; 3-state

### TSSOP24: plastic thin shrink small outline package; 24 leads; body width 4.4 mm

SOT355-1



UNIT	A max.	A <sub>1</sub>	A <sub>2</sub>	A <sub>3</sub>	bp	С	D <sup>(1)</sup>	E <sup>(2)</sup>	Ф	HE	L	Lp	ø	v	¥	у	Z <sup>(1)</sup>	θ
mm	1.1	0.15 0.05	0.95 0.80	0.25	0.30 0.19	0.2 0.1	7.9 7.7	4.5 4.3	0.65	6.6 6.2	1	0.75 0.50	0.4 0.3	0.2	0.13	0.1	0.5 0.2	8° 0°

#### Notes

- 1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.
- 2. Plastic interlead protrusions of 0.25 mm maximum per side are not included.

VERSION IEC JEDEC JEITA PROJECTION 99-12-27	OUTLINE	REFERENCES			EUROPEAN	ISSUE DATE	
SO(355-1) $MO(-153)$ $+++++++++++++++++++++++++++++++++++$	VERSION	IEC	JEDEC	JEITA		PROJECTION	ISSUE DATE
03-02-19	SOT355-1		MO-153				<del>99-12-27</del> 03-02-19

Fig 10. Package outline SOT355-1 (TSSOP24)

74ABT82

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10-bit buffer/line driver; non-inverting; 3-state

# 13. Abbreviations

### Table 9. Abbreviations

Acronym	Description
BiCMOS	Bipolar Complementary Metal-Oxide Semiconductor
DUT	Device Under Test
ESD	ElectroStatic Discharge
НВМ	Human Body Model
MM	Machine Model

# 14. Revision history

### Table 10. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
74ABT827 v.5	20111107	Product data sheet	-	74ABT827 v.4
Modifications:	<ul> <li>Legal pages</li> </ul>	s updated.		
74ABT827 v.4	20100401	Product data sheet	-	74ABT827 v.3
74ABT827 v.3	20100224	Product data sheet	-	74ABT827 v.2
74ABT827 v.2	19980116	Product specification	-	74ABT827 v.1
74ABT827 v.1	19950906	Product specification	-	-

10-bit buffer/line driver; non-inverting; 3-state

# 15. Legal information

### 15.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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- [2] The term 'short data sheet' is explained in section "Definitions"
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## 10-bit buffer/line driver; non-inverting; 3-state

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